

Los Alamos National Laboratory, an affirmative action/equal opportunity employer, is operated by the University of California for the U.S. Department of Energy under contract W-7405-ENG-36. By acceptance of this article, the publisher recognizes that the U.S. Government retains a nonexclusive, royalty-free license to publish or reproduce the published form of this contribution, or to allow others to do so, for U.S. Government purposes. The Los Alamos National Laboratory requests that the publisher identify this article as work performed under the auspices of the U.S. Department of Energy.

BEAM-PROFILE INSTRUMENTATION FOR BEAM-HALO MEASUREMENT: OVERALL DESCRIPTION AND OPERATION*

J. D. Gilpatrick, D. Barr, L. A. Day, D. M. Kerstiens, M. Stettler, R. Valdiviez, LANL, Los Alamos, NM, 87545, USA

M. Gruchalla, J. F. O'Hara, Honeywell Corporation, Albuquerque, NM, ????, USA J. H. Kamperschroer, General Atomics Corporation, San Diego, CA, ????, USA

Abstract

Within the halo experiment presently being conducted at the Low Energy Demonstration Accelerator at Los Alamos National Laboratory, specific beam instruments that acquire horizontally and vertically projected particledensity distributions out to greater than 10⁵:1 dynamic range are located throughout the 52-magnet halo lattice. We measure the core of the distributions using traditional wire scanners, and the tails of the distribution using watercooled graphite scraping devices. The wire scanner and halo scrapers are mounted on the same moving frame whose location is controlled with stepper motors. A sequence within the experimental physics and industrial control system (EPICS) software communicates with a National Instrument LabVIEW virtual instrument to control the motion and location of the scanner/scraper assembly. Secondary electrons from the wire scanner 0.03-mm carbon wire and protons impinging on the scraper are both detected with a lossy-integrator electronic circuit. Algorithms implemented within EPICS and in Research Systems Interactive Data Language subroutines analyze and plot the acquired distributions. This paper describes this beam profile instrument, describes our experience with its operation, compares acquired profile data with simulation, and refers to other detailed papers.

1 HALO INSTRUMENTATION

At LEDA a 100-mA, 6.7-MeV beam is injected into a 52-quadrupole magnet lattice (see fig. 1). Within this 11m FODO lattice, there are nine wire scanner/halo scraper/wire scanner (WS/HS) stations, five pairs of steering magnets and beam position monitors, five loss monitors, three pulsed-beam current monitors, and two image-current monitors for monitoring beam energy [1]. The WS/HS instrument's purpose is to measure the beam's transverse projected distribution. These measured distributions must have sufficient detail to understand beam halo resulting from upstream lattice mismatches [2.3]. The first WS/HS station, located after the fourth quadrupole magnet, verifies the beam's transverse characteristics after the RFO exit. A cluster of four HS/WS located after magnets #20, #22, #24, and #26 provides phase space information after the beam has debunched. After magnets #45, #47, #49, and #51 reside the final four WS/HS stations. These four WS/HS acquire projected beam distributions under both matched and mismatched conditions. These conditions are generated by adjusting the first four quadrupole magnets fields so that the RFQ output beam is matched or mismatched in a known fashion to the rest of the lattice. Because the halo takes many lattice periods to fully develop, this final cluster of WS/HS are positioned to be most sensitive to halo generation.



Figure 1. The 11-m, 52-magnet FODO lattice includes nine WS/HS stations that measure the beam's transverse projected distributions.

As the RFQ output beam is mismatched to the lattice, the WS/HS actually observe a variety of distortions to a properly matched Gaussian-like distribution [2,3]. These distortions appear as distribution tails or backgrounds. It is the size, shape, and extent of these tails that predicts specific type of halo. However, not every lattice WS/HS observes the halo generated in phase space because the resultant distribution tails may be hidden from the projection's view. Therefore, multiple WS/HS are used to observe the various distribution tails.

2 WS/HS DESCRIPTION

Each station consists of a horizontal and vertical actuator assembly (see fig. 2) that can move a 33-mmcarbon monofilament and two graphite/copper scraper sub-assemblies [4]. The carbon wire and scrapers are connected to the same movable frame. Attached to this movable frame is a linear encoder that provides the wire

^{*} Work supported by the US DOE, Defense Programs and by the US DOE, Nuclear Energy.

and scraper edges' relative position to within 5 mm, an additional linear potentiometer provides an absolute approximate position for LEDA's run permit systems. A stepper motor and ball lead screw drive the actuated moveable frame, and microswitches and motor brakes limit the wire and scraper movement.



Figure 2. The WS/HS assembly contains a movable frame on which a 0.03-mm carbon wire resides between two water-cooled graphite scrapers.

The carbon wire, which senses the beam's core, is cooled by thermal radiation. If the beam macropulse is too long, the wire temperature continues above 1800 K resulting in the onset of thermionic emission [5]. Thermionic emission gives the distribution an inaccurate appearance of a larger distribution core current density. To eliminate these effects for the halo experiment, the maximum pulse length and repetition rate is limited to approximately 30 ms and 1 Hz, respectively.

The halo scrapers are composed of a 1.5-mm thick graphite plate brazed to a water-cooled 1.5-mm thick copper plate. Since 6.7-MeV protons average range in carbon is approximate 0.3 mm, the beam is completely stopped within the graphite plate. Cooling via conduction lowers the average temperature of scraper sub-assembly and allows the scraper to be cooled more rapidly than the wire. The lower average temperature and faster cooling allows the scraper to be driven in as far as 2 rms widths from the beam distribution peak without the peak temperature increasing above 1800 K.

The movement and positioning of each wire and scraper pair is controlled by a movement control system that contains a stepper motor, stepper motor controller, a linear encoder, and an electronic driver amplifier [6]. The controller's digital PID loop controls the speed and accuracy at which the assembly is moved and placed.

The target position, as defined by the WS/HS operator, is relayed from the EPICS control screen via a database process variable to a National Instruments LabVIEW Virtual Instrument (VI). The VI also calibrates the relative position of the linear encoders based on the measured position of the limit switches, and provides some error feedback information [6]. The total error between the target wire position and the actual position attained are <+/-2% of a 1-mm width beam (see fig. 3).

As the wire is moved through the beam, it senses the projected beam core distribution. A small portion of the beam's energy is imparted to the wire causing secondary electron emission to occur. The secondary electrons leaving the wire are replaced by negative charge flowing from the electronics. This current flow for both axes is connected through a bias battery to an electronic lossy integrator circuit and followed by an amplification stage.



The integrator capacitance and amplifier gain are set to allow a very wide range of values of accumulated charge [7]. Data are acquired by digitizing the accumulated charge through the lossy integrator at two different times within the beam pulse. This charge difference acquired by subtracting the two values of charge provides a low noise method of relative beam charge acquisition. The wire and scraper accumulated charge signals are digitized using 12-bit digitizers. The analog noise floor has been measured to be 0.03 pC, a noise level slightly lower than the scraper digital LSB noise level of 0.6 pC using the highest gain settings within the detection electronics.

The front-end electronic circuitry, mounted on a daughter printed circuit board, is connected to a motherboard that has all of the necessary interface electronics to communicate with EPICS via a controller module and within the same electronics crate. A software state machine sequence was written within EPICS to control and operate WS/HS instrumentation [8]. The state machine instructs the VI to move the wire and scraper to a specific location, acquire synchronous distribution data from either the wire or scraper, and triggers the IDL routine to normalize the acquired charge with a nearby toroidal current measurement, graph the normalized data, and write the distribution to a file. The sequence also instructs IDL to calculate the first through fourth moments, fit a Gaussian distribution to the wire scanner data, and calculate the point at which the beam distribution disappears into the distribution background noise,

To plot the complete beam distribution for each axis, the wire scanner and two scraper data sets must be joined [9]. To accomplish this joining, several analysis tasks are performed on the wire and scraper data including,

(1) scraper data are spatially differentiated and averaged,

(2) wire and scraper data are acquired with sufficient spatial overlap, and

(3) differentiated scraper data are normalized to the wire beam core data.

The scraper data need only be normalized in the relative charge axis since the distances between each wire and scraper edge are known to within 0.25-mm. In addition, the first four moments and the point at which the

beam distribution disappears into the noise are also calculated for the combined distribution data.

3 ACQUIRED DISTRIBUTIONS

Fig. 4 shows data from WS/HS #26 with some slight mismatch generated by increasing the field above nominal by 5% in the first matching quadrupole magnet. These typical WS/HS profiles show distributions with a dynamic range of $> 10^5$:1 and provide distribution information to > 5X to 7X times typical rms widths of the beam. The calculated rms widths are 1.10 and 1.13 mm for the horizontal and vertical distributions, respectively. The points at which the distributions rises out of the noise are 5.9 and -8.2 mm for the horizontal axis and 5.8 and -6.7 mm for the vertical axis.



Figure 4. WS/HS distributions, such as #26 shown here, have a typical dynamic range of $> 10^5$:1.

4 WIRE AND SCRAPER PHYSICS

The WS wire is biased negative to optimize secondary emission (S.E.) yield where the yield is defined as the ratio of the emitted secondary electron current and the proton beam current intercepted by the wire. Table 1 shows the measured values of a representative sample of the lattice and HEBT WS wires. All of the wires in the halo lattice WS are configured with a 33- μ m, carbon monofilament. The HEBT WS is configured with a 100- μ m SiC wire.

Table 1	:	Measured	Secondary	Emission	Yields
---------	---	----------	-----------	----------	--------

WS	X/Y Beam Current (mA)	X/Y Rms Width (mm)	X/Y S. E. Current (mA)	X/Y Yields (%)
22	75/76	0.86/0.67	0.63/0.6	55/41
24	76/76	0.78/0.88	0.55/0.61	42/54
47	76/76	0.7/0.75	0.6/0.6	42/47
51	77/77	0.8/0.77	0.65/0.61	51/46
HEBT	75/75	5/8.2	0.30/0.24	51/66

The choice of bias potential was determined by measuring the wire and scraper currents as a function of bias potential. The resulting data showed that the wire is optimally biased at -6 to -12 V and the scraper is optimally biased at +20 to +30 V [10].

As the wire bias is positively increased from 0 V to > +100 V, the wire secondary electron emission is inhibited and the net wire current reduces to very near zero. As expected, a large positive bias reduces the wire detection

signal. Furthermore, it appears that the wire collects positive ions with < -25 V bias potentials well after the beam pulse. This ion collection additionally limits the amount of negative bias that is applied to the wire for proper secondary emission operation.

The scraper detection goal is to inhibit secondary emission and detect only 6.7-MeV protons. With 0 V applied to the scraper, the scraper net current is elevated by a factor of X3, likely from secondary emission. With approximately +25 V bias applied to the scraper, the secondary emission is almost entirely inhibited and the net current reduces to the nominal proton current.

5 SUMMARY

A wire scanner and halo scraper have been integrated into a beam profile instrument capable of 105:1 dynamic range. The scanner and scraper V-I curves show that the wire and scraper are optimally biased at -12 V and +25 V, respectively. The S.E. yields from the lattice WS wires have typically been between 40% and 55%.

6 REFERENCES

- [1] J. D. Gilpatrick, et al., "Experience with the Low Energy Demonstration Accelerator (LEDA) Halo Experiment Beam Instrumentation," published at this conference.
- [2] T. Wangler, et al., "Experimental Study of Proton-Beam Halo Induced by Beam Mismatch in LEDA," published at this conference.
- [3] P. L. Colestock, et al., "Measurements of Halo Generation for a Proton Beam in a FODO Channel," published at this conference.
- [4] R. Valdiviez, et al., "The Final Mechanical Design, Fabrication, and Commissioning of a Wire Scanner and Scraper Assembly for Halo-Formation Measurements in a Proton Beam," published at this conference.
- [5] R. Valdiviez, et al., "The High-Heat Flux Testing of an Interceptive", published at this conference.
- [6] D. Barr, et al., "Design and Experience with the WS/HS Assembly Movement Using LabVIEW VIs, National Instrument Motion Controllers, and Compumotor Electronic Drive Units and Motors," published at this conference.
- [7] M. Gruchalla, et al., "Beam Profile Wire-Scanner/Halo-Scraper Sensor Analog Interface Electronics," published at the conference.
- [8] L. Day, et al., "Automated Control and Real-Time Data Processing of Wire Scanner/Halo Scraper Measurements," published at this conference.
- [9] J. Kamperschroer, et al., "Analysis of Data from the LEDA Wire Scanner/Halo Scraper," published at this conference.
- [10] J. D. Gilpatrick, et al., "Beam-Profile Instrumentation For A Beam-Halo Measurement: Overall Description, Operation, And Beam Data," DIPAC2001, Grenoble, France, May 13-15, 2001.